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*detecting the future*

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# ***Large-area CdTe pixel detectors for high-energy X-ray applications***

***D. Šišak Jung, T. Donath, J. Bednarcik, M. di Michael, S. Jacques  
PPXRD-14, Fort Myers, Florida, 6.06.-9.06.2016***

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ICDD Website - [www.icdd.com](http://www.icdd.com)

# High-energy X-rays?

## 1. (free) Definition

- *Laboratory: > 8 keV (Cu-source)*
- *Synchrotron: > 60 keV*
- *Detector: > 40 keV*

## 2. Properties

- *Higher penetration depth*

## 3. Use (in material analysis)

- *Imaging techniques*
- *Scattering (and diffraction)*

## 4. Technical aspects

- *Laboratory tube: energy; flux*
- *Detector*

# ***High-energy X-rays in pharmaceutical science***

***1. Computed Tomography (CT) techniques***

***2. Real-time/in situ X-Ray Powder Diffraction (XRPD)***

***3. Pair Distribution Function (PDF) technique***

# ***High-energy X-rays in pharmaceutical science***

***1. Computed Tomography (CT) techniques***

***2. Real-time/in situ X-Ray Powder Diffraction (XRPD)***

***3. Pair Distribution Function (PDF) technique***

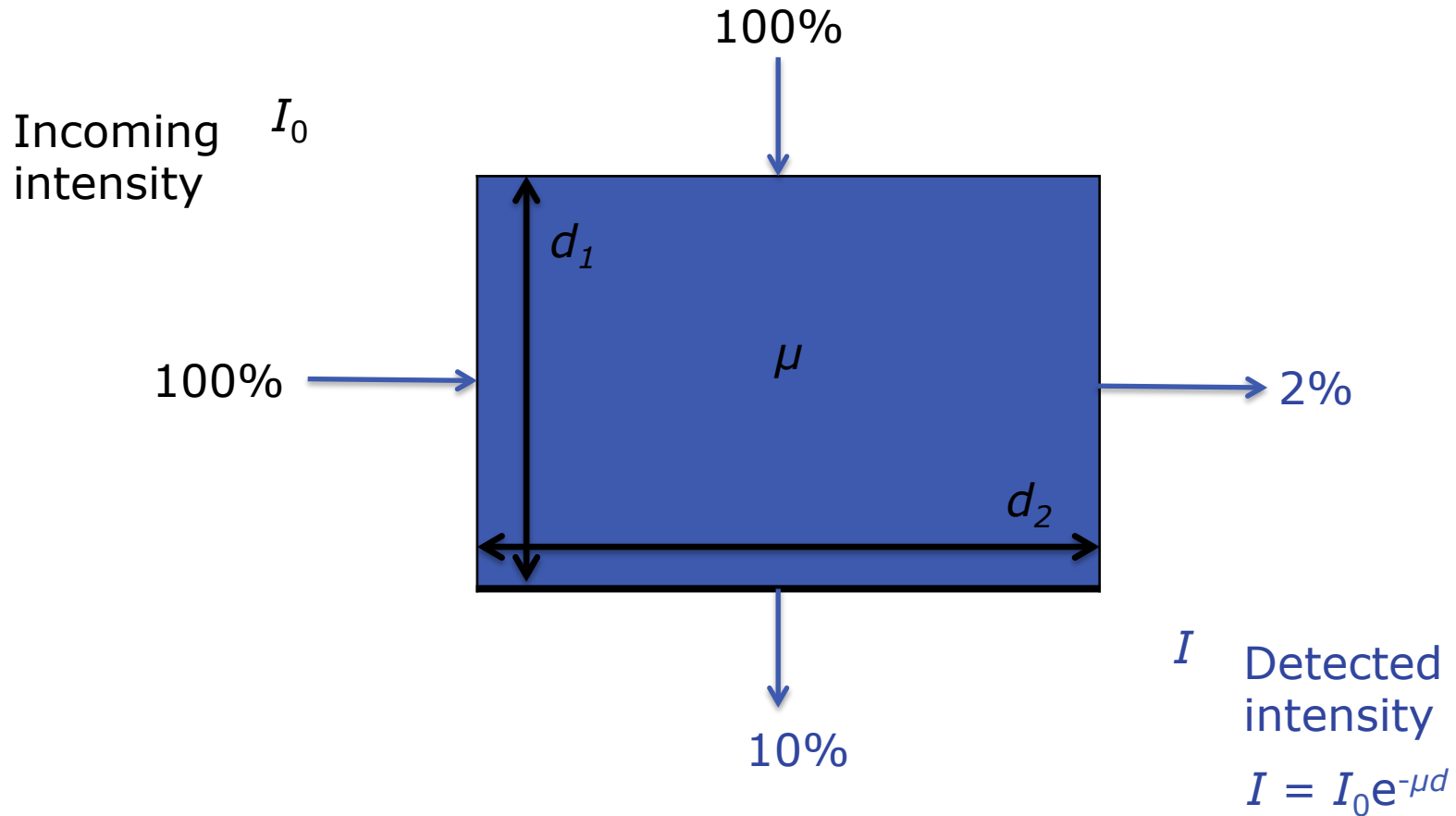
***4. XRPD-CT***

*– Spatially resolved chemical insight (crystalline materials)*

***5. PDF-CT***

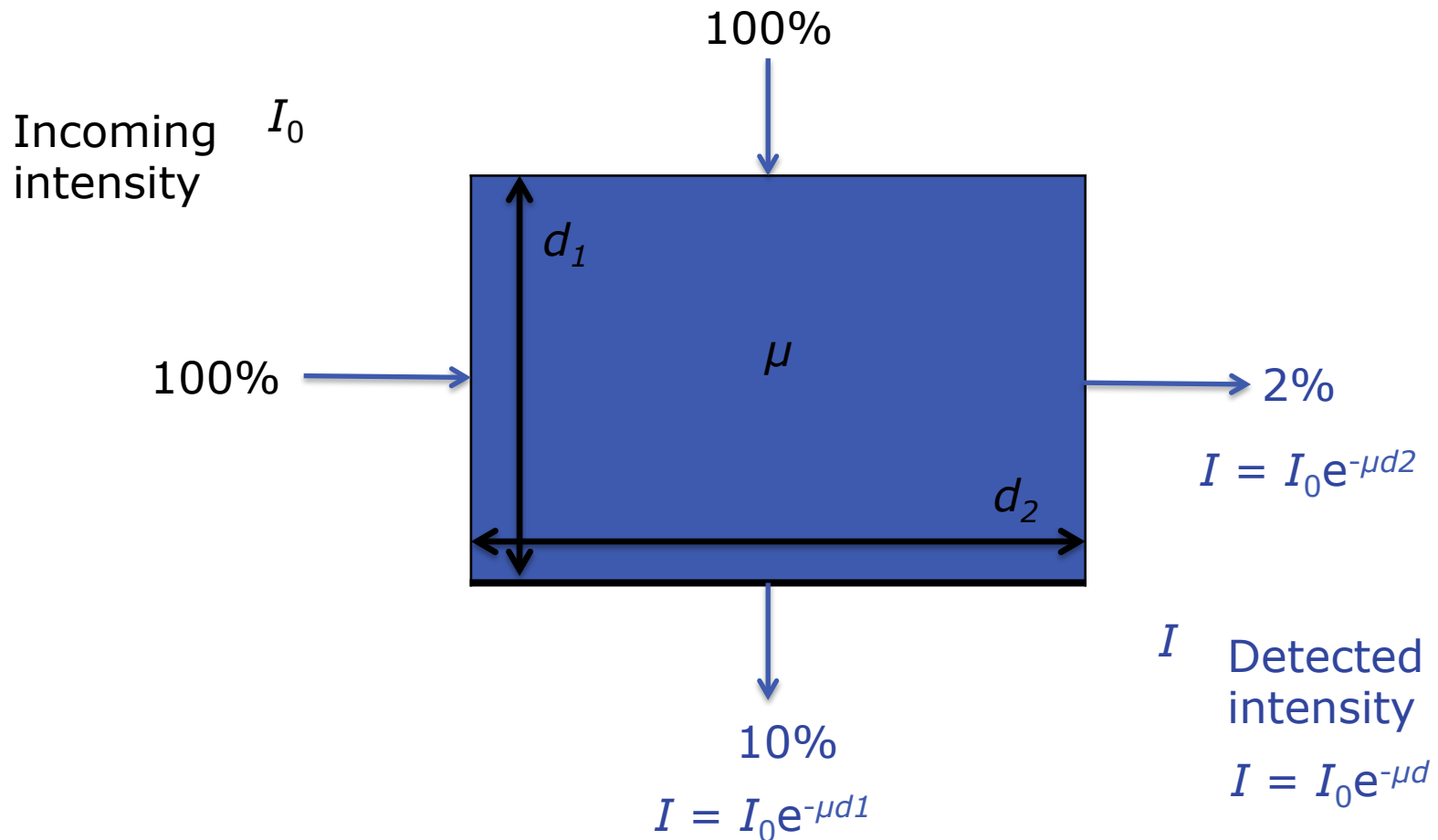
*– Spatially resolved chemical insight (nanocrystalline and amorphous materials)*

# CT principle



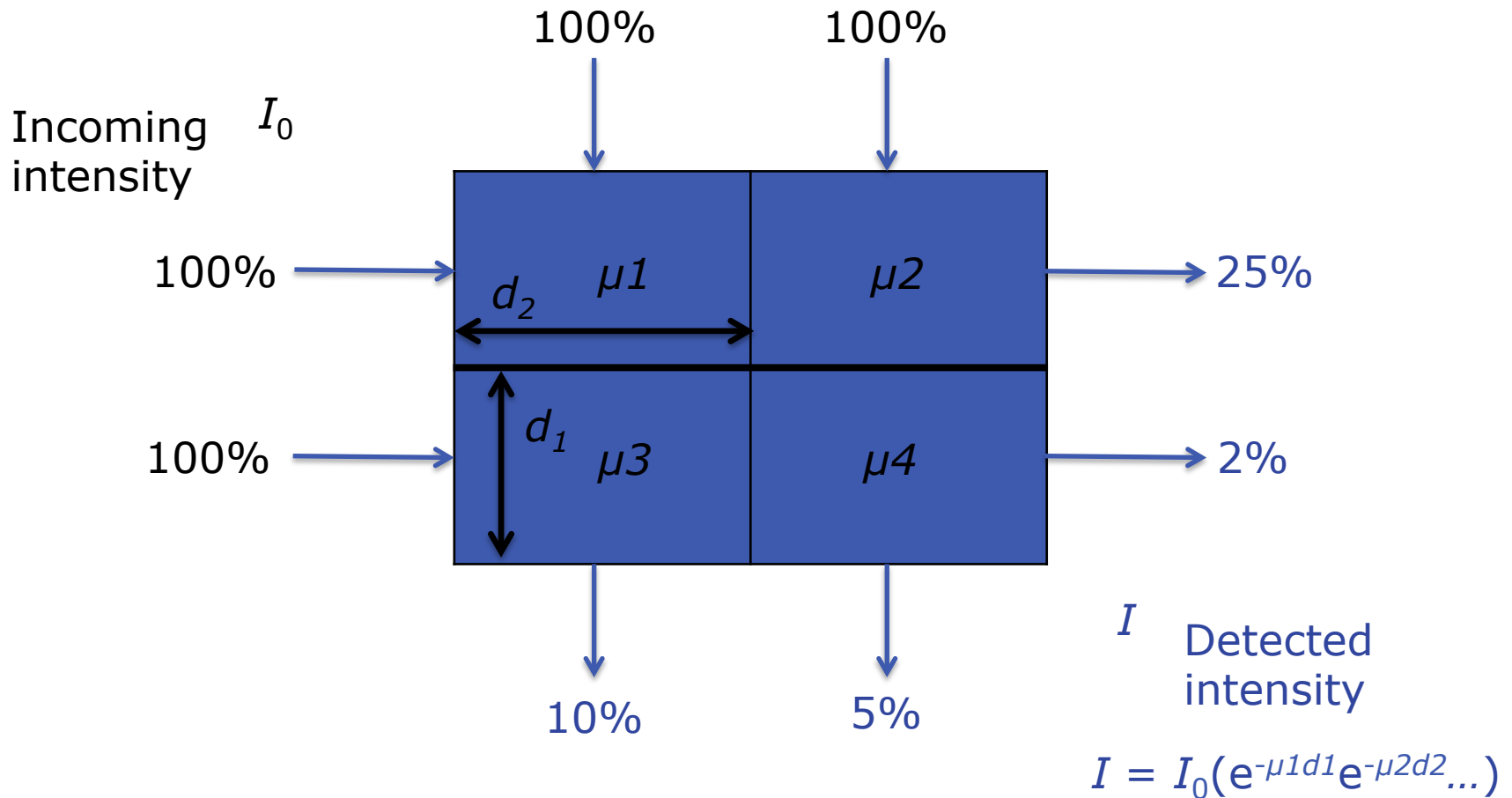
Simplified visualization of Lambert-Beer law on attenuation of light caused by the properties of a material which the light is travelling through.

# CT principle



Simplified visualization of Lambert-Beer law on attenuation of light caused by the properties of a material which the light is travelling through.

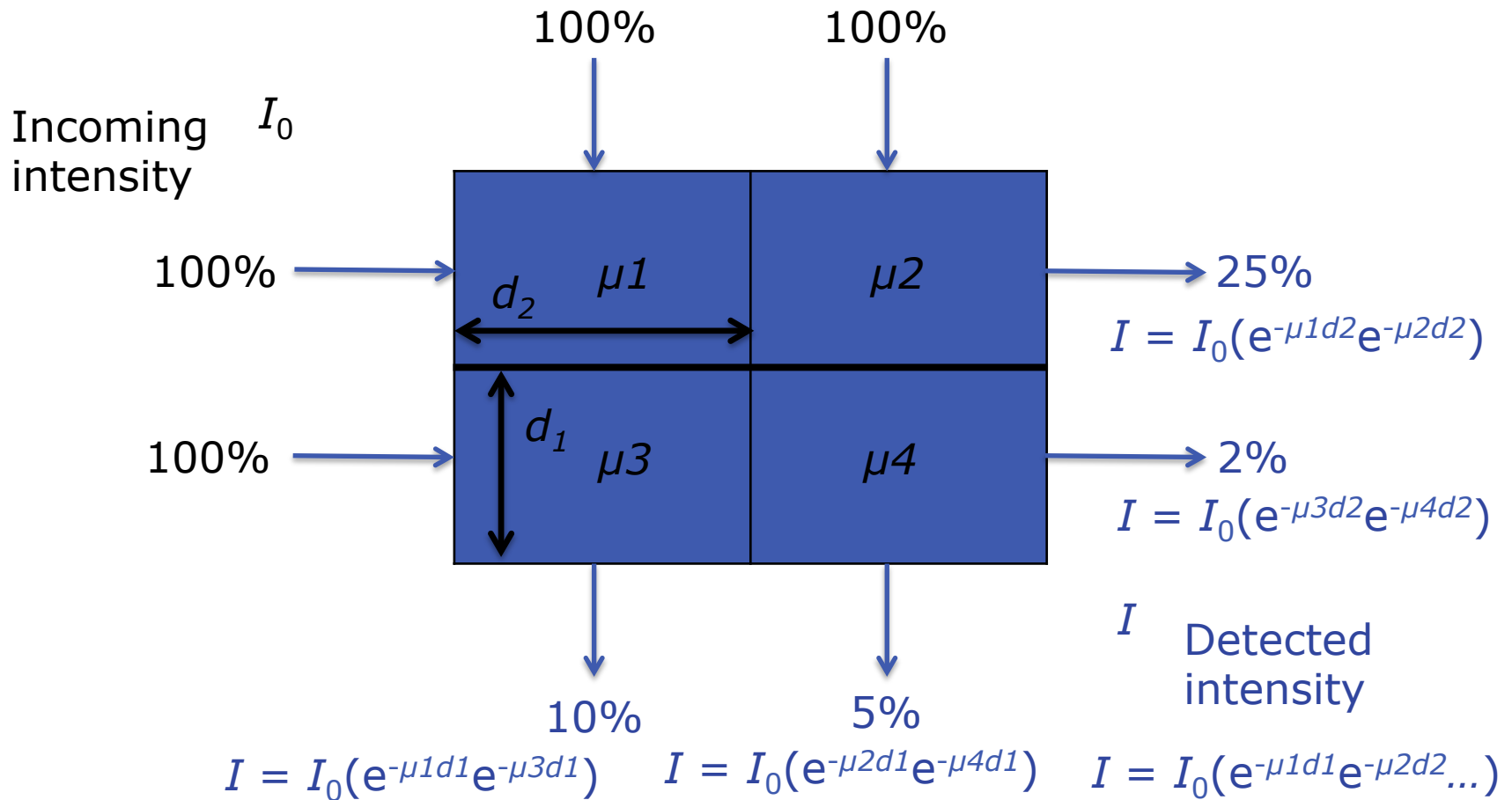
# CT principle



Expansion of Lambert-Beer law on to objects that comprise four different Materials with different absorption coefficients.

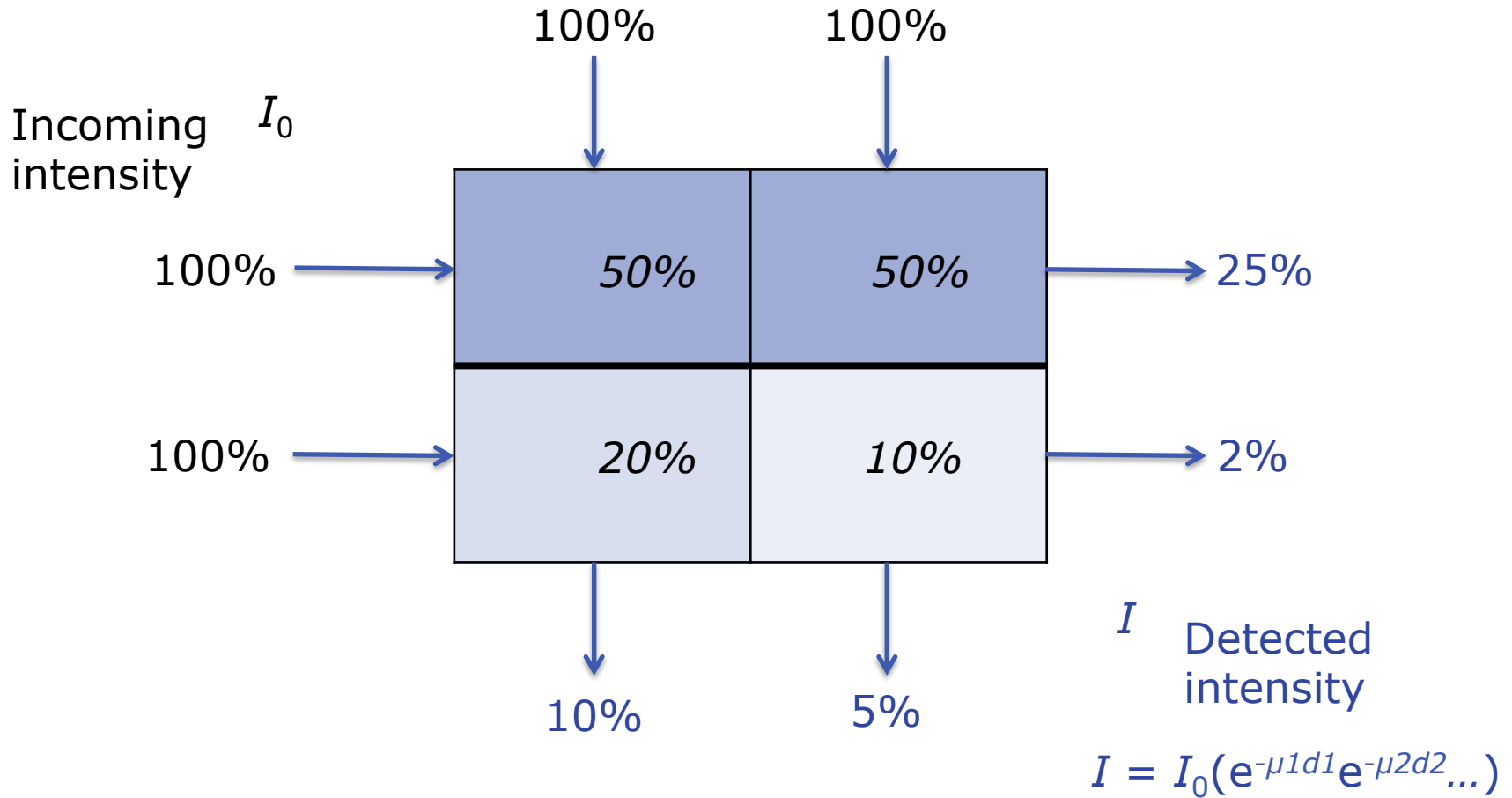


# CT principle



Expansion of Lambert-Beer law on to objects that comprise four different Materials with different absorption coefficients.

# CT principle



Expansion of Lambeert-Beer law on to objects that comprise four different Materials with different absorption coefficients.

# ***CT for investigation of porosity of granules***

## **1. Objective**

- *Analyze size, shape and distribution of pores within granules because pores influence dry strength, dissolution and disintegration in liquid medium*

## **2. Standard method(s)**

- *Mercury porosimetry*
- *Gas adsorption*

## **3. New method**

- *CT*

# ***CT for investigation of porosity of granules***

## ***1. Measurement***

- Scanning time 1 hour*

## ***2. Result***

- 10% uncertainty due to relatively low signal-to-noise ratio*

# ***CT for investigations of density variations in tablets***

## ***1. Objective***

- Analyze density variations in a tablet*

## ***2. Standard method(s)***

- Differential matching*
- Hardness tests*
- X-ray shadow of lead grids placed in a compact*

## ***3. New method(s)***

- CT*

# ***CT for investigations of density variations in tablets***

## ***1. Measurement***

- Multiple steps due to artifacts of a detector*

## ***2. Result***

- Density plot of two tablets with 3D information about the spatial distribution of the components*

# *In situ XRPD*

## **1. Aim**

- *Investigate processes in situ (in operando): solid-state reaction(s) during milling*
- *X-rays that are able to penetrate the mill*

## **2. Method**

- *High Energy X-Ray Powder Diffraction used on a specifically designed mill*

## **3. Results**

- *Time-resolved structural information of reactants, impurities and (meta)stable product(s)*

# PDF for nanopharmaceuticals

## 1. Aim

- *PDF for analysis of amorphous and nanocrystalline compounds presents a probability of finding pairs of atoms at a real-space distance in a probed volume.*

## 2. Method

- *X-ray (total) scattering experiments, performed at energies usually higher than 60 keV*
- *Exposure time 1-10 s using 2D detectors*

## 3. Results

- *Information about non-crystalline phase(s)*

Billinge, S.J.L. *et al.* (2004) *Chem. Comm.* 749-760  
Billinge, S.J.L. (2015) *Nanomedicine* **10**, 2473-2475.



# PDF for nanopharmaceuticals

## 1. Method for

- *API/Excipient/Formulation control and identification*
- *Stability studies*
- *Particle size control*
- *Quantification (residual crystalline sample)*

## 2. Improvements

- *Synchrotrons*
- *2D detectors*

## 3. Challenges

- *Collecting wide solid angle fast (detector size)*
- *Collecting PDF data in laboratory (Mo, Ag source)*
- *Radiation damage*

Thakral, S. Et al. (2016) *Adv. Drug Deliv. Rev.* **100**, 183-193.  
Billinge, S.J.L. (2015) *Nanomedicine* **10**, 2473-2475.

# XRD-CT

## 1. Aim

- *Spatial identification of crystalline compounds present in a sample*
- *Crystallization and preferred crystal orientation in a stirred reactor (in situ)*

## 2. Method

- *Synchrotron-based tomographic energy dispersive diffraction imaging (TEDDI)*

## 3. Limitations

- *Crystallization rates limited by the speed of data acquisition (30 s per point)*

# PDF-CT

## 1. Aim

- *Spatial identification of non-crystalline compounds present in a sample*

## 2. Method

- *X-ray (total) scattering measurements combined with computed tomography*

# ***High-energy applications: Problems***

## ***1. Tubes***

## ***2. Algorithms***

## ***3. Detectors (specifically for in-house measurements)***

- Noise*
- Speed*
- Efficiency*
- Size*
- Availability*

# ***High-energy applications: Problems***

***1. Tubes ✓***

***2. Algorithms ✓***

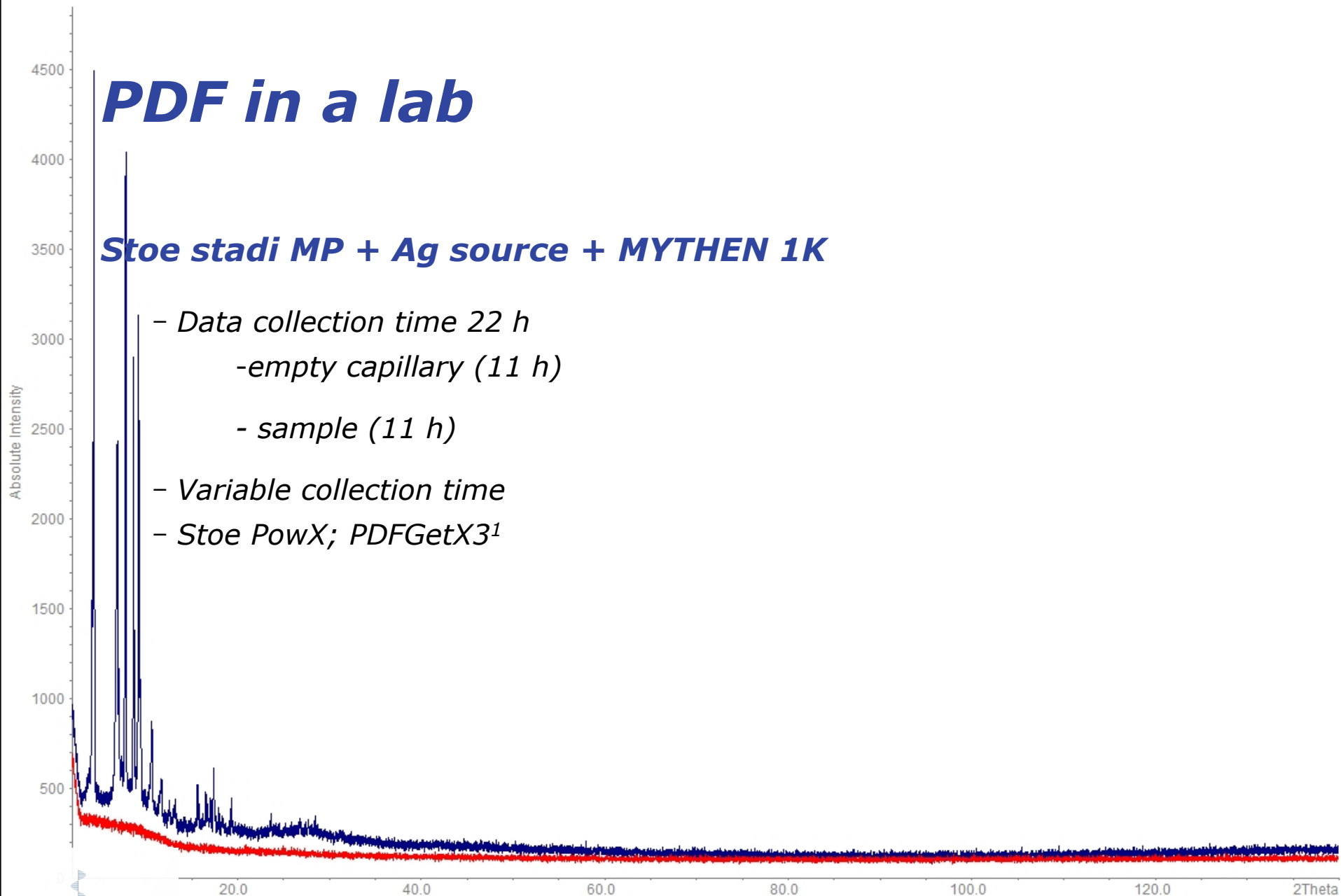
***3. Detectors (specifically for in-house  
measurements) ✓***

- Noise*
- Speed*
- Efficiency*
- Size*
- Availability*

# PDF in a lab

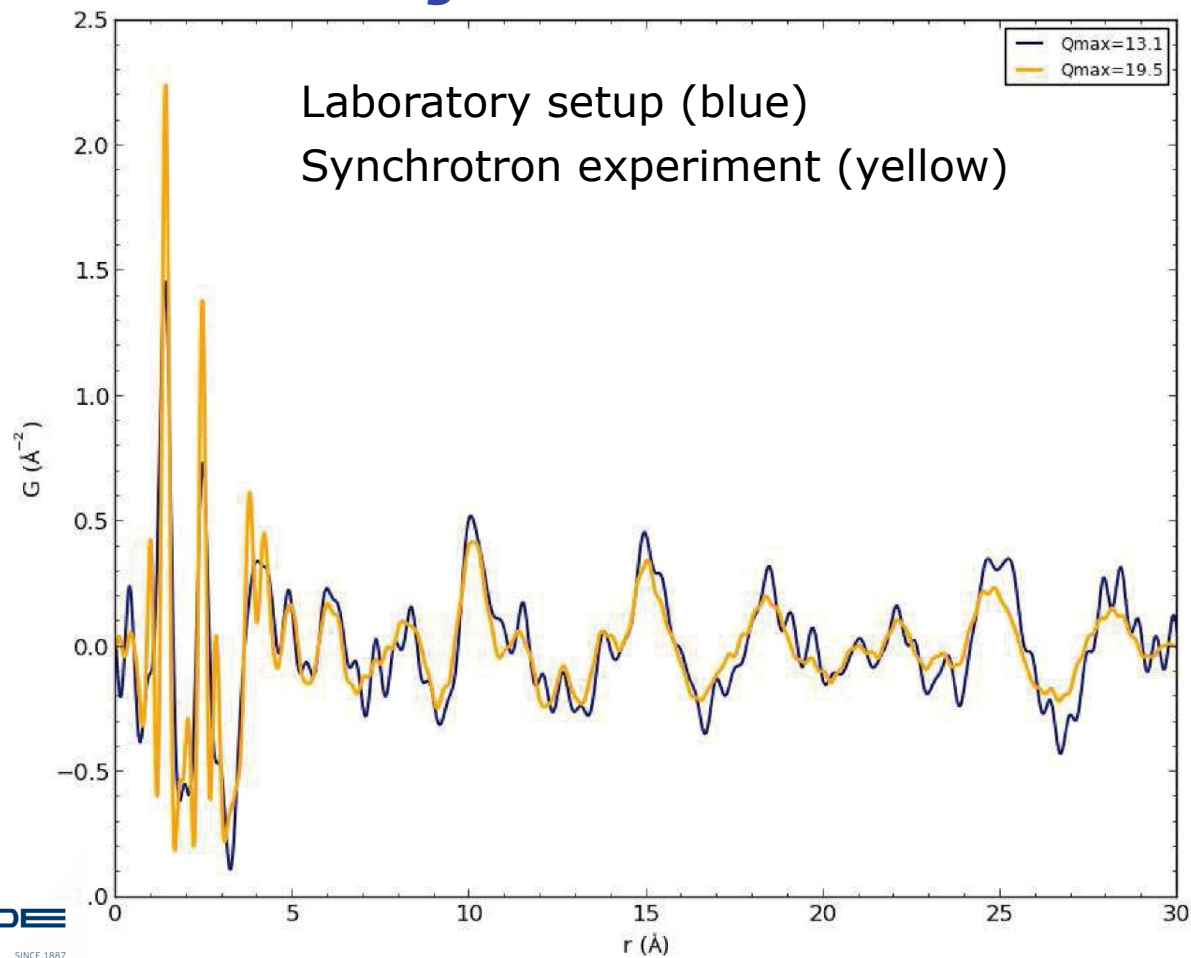
**Stoe stadi MP + Ag source + MYTHEN 1K**

- Data collection time 22 h
- empty capillary (11 h)
- sample (11 h)
- Variable collection time
- Stoe PowX; PDFGetX3<sup>1</sup>



# PDF in a lab

**Stoe stadi MP + Ag source + MYTHEN 1K**



# ***High-energy applications: Problems***

***1. Tubes ✓***

***2. Algorithms ✓***

***3. Detectors (specifically for in-house  
measurements) ✓?***

- Noise*
- Speed*
- Efficiency*
- Size*
- Availability*



# Detectors

## 1. Noise

- *Hybrid Photon Counting (HPC) technology*

## 2. Speed

- *Special design of the readout chip*
- *Firmware*

## 3. Efficiency

- *Sensor material responsive to high-energies*

## 4. Size

- *Growth/processing of sensor material*

## 5. Availability

- *Price*
- *Calibration(s)*

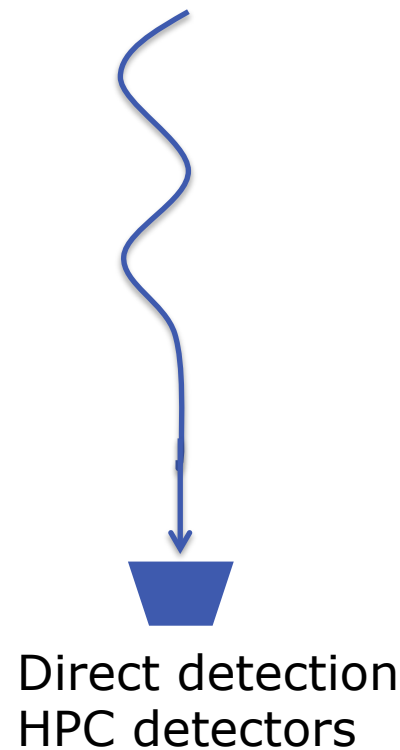
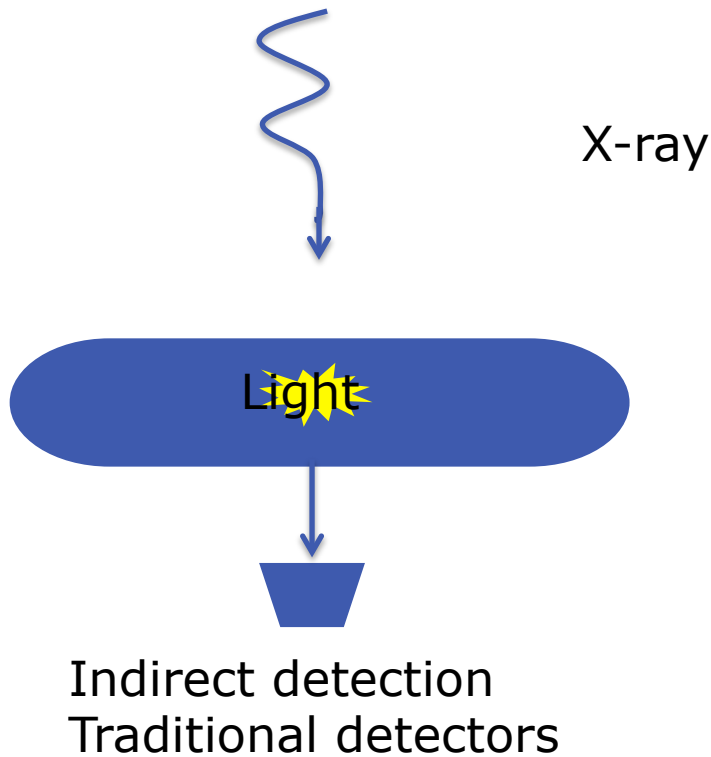
# PILATUS3 CdTe



Loeliger, T. *et al.*, Proc. IEEE Nuclear Science Symposium and Medical Imaging Conference (NSS/MIC), 2012, 610.

# PILATUS3 CdTe

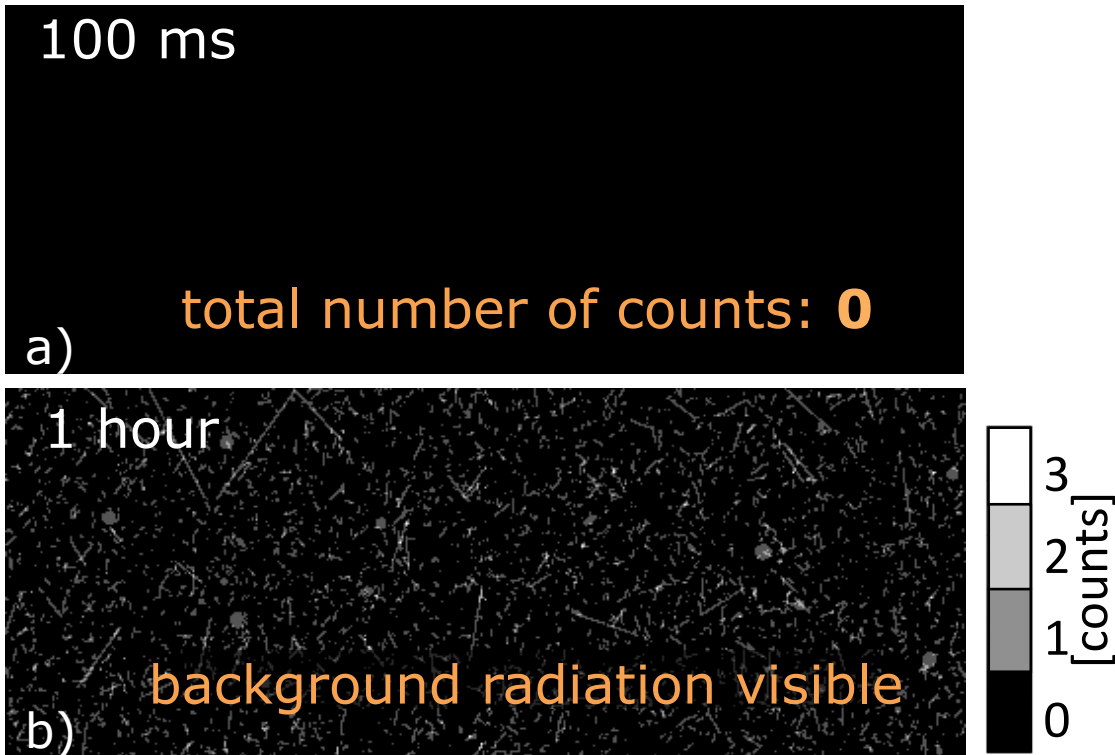
*Hybrid Photon Counting (HPC) = Direct detection of X-rays*



- noise-free performance

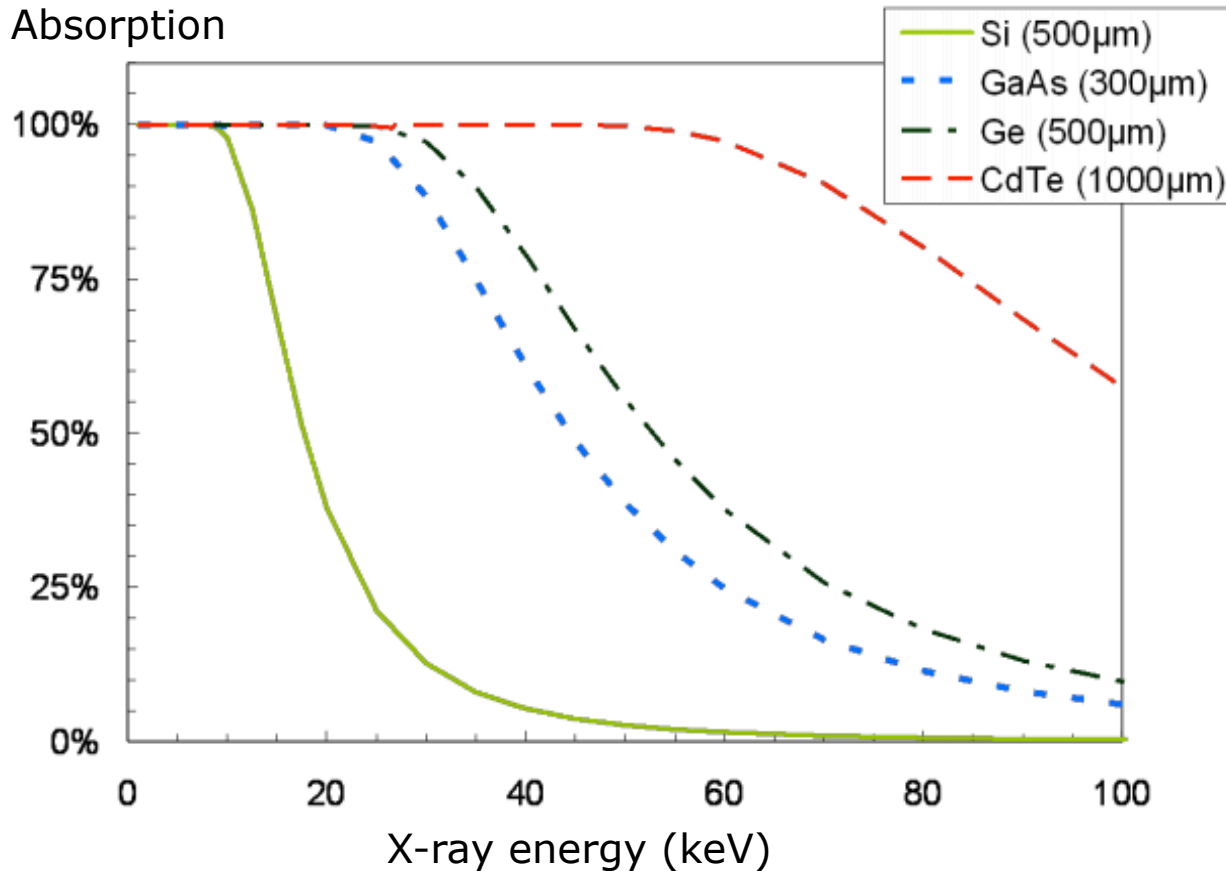
# PILATUS3 CdTe

*Hybrid Photon Counting (HPC) = no-noise performance*



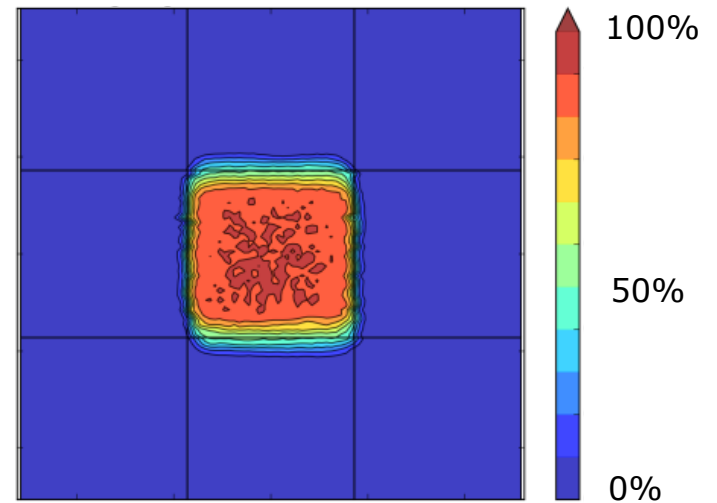
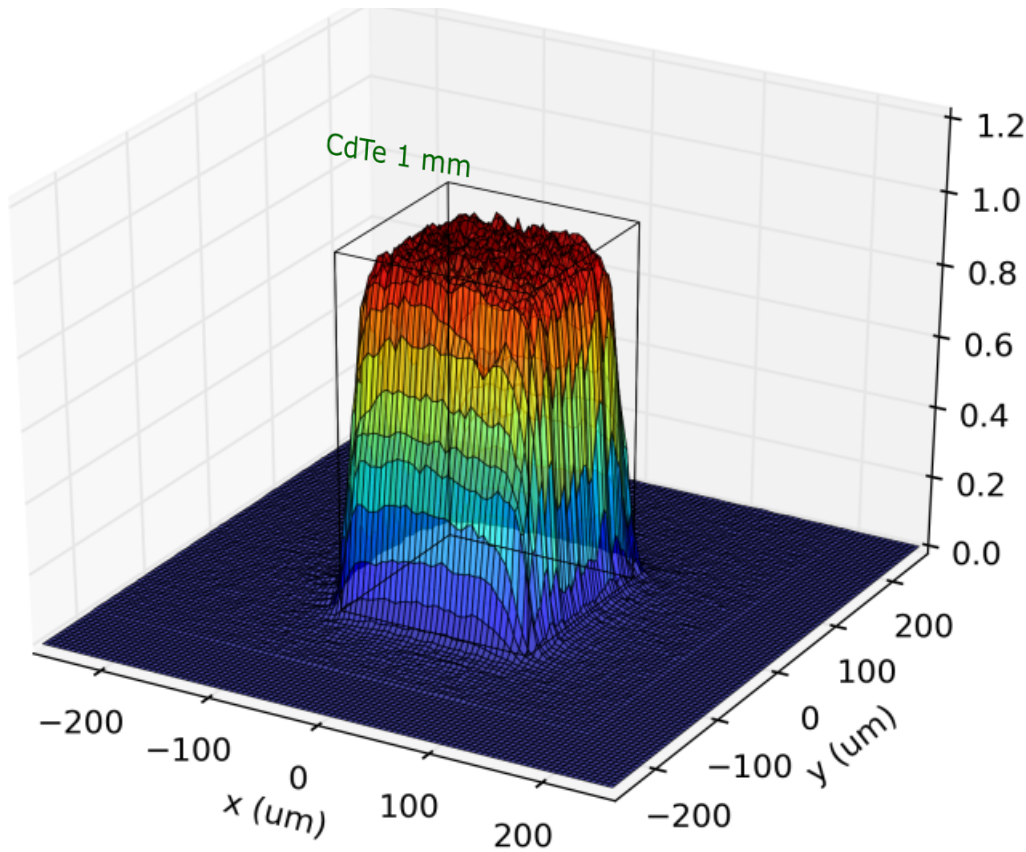
Images collected with PILATUS 100K detector using exposure time 100 ms and b) 1h. Both images are free of readout noise and dark current.

# PILATUS3 CdTe



Absorption of different material sensors calculated for energy range 0-100 keV.

# PILATUS3 CdTe



Pixel response scanned using a 10  $\mu\text{m}$  diameter pinhole.

# ***PILATUS3 CdTe***

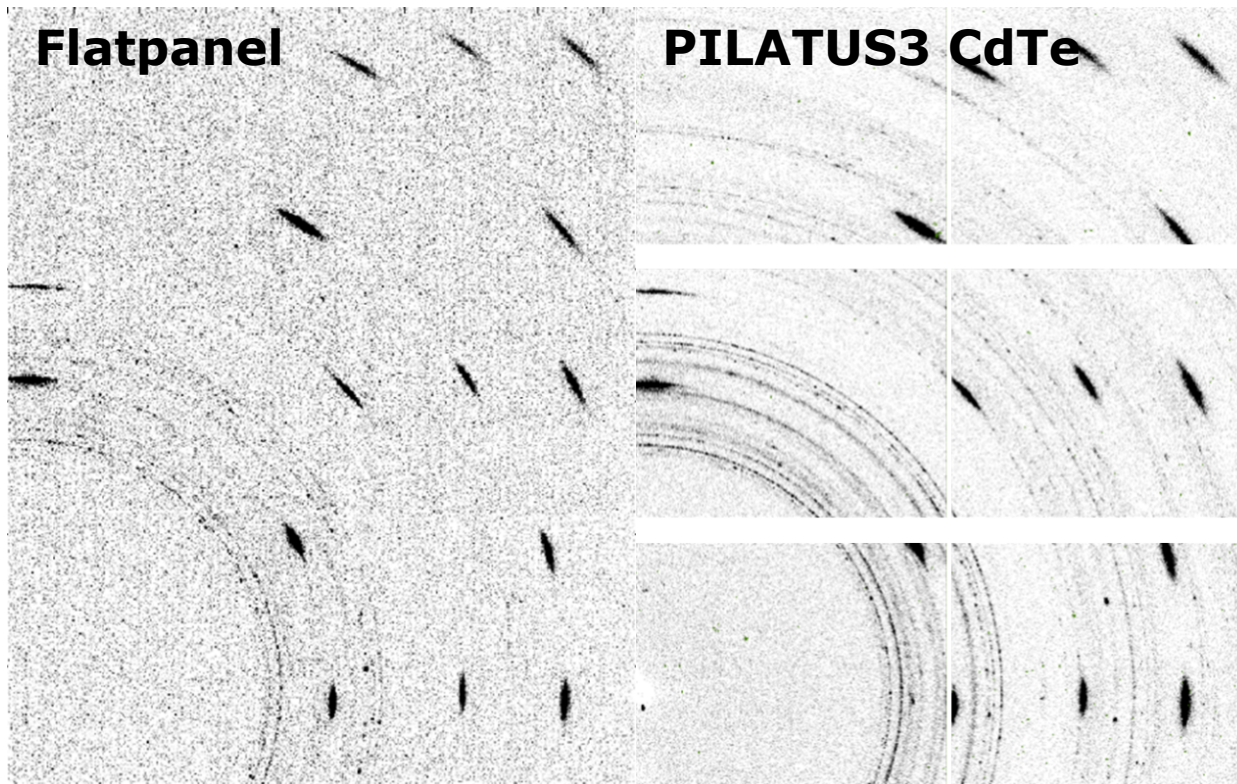
***Tests at synchrotron sources:***

***XRPD***

***PDF***

***XRPD-CT***

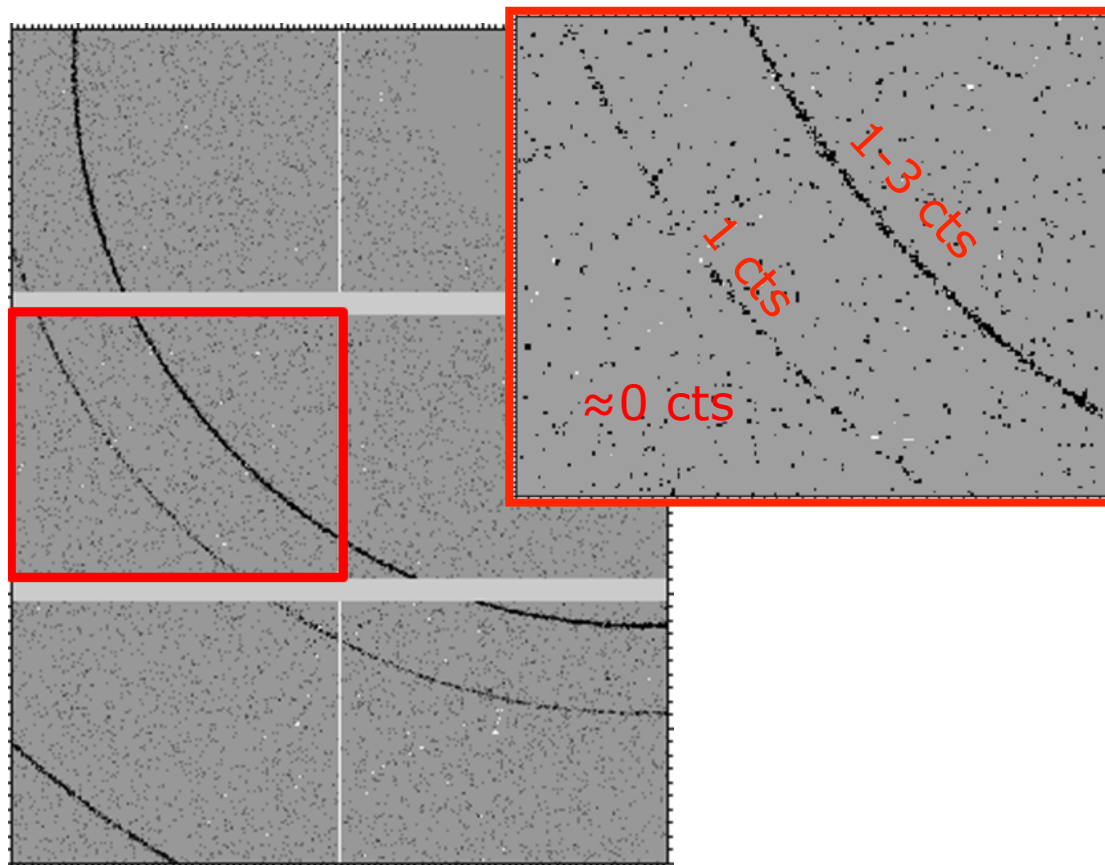
# XRPD (ESRF, ID15)



Two XRPD patterns of a superconducting filament containing  $\text{Nb}_3\text{Sn}$  powder in a tungsten tube ( $\text{Ø}50\mu\text{m}$ ). Both patterns are recorded at 46.3 keV, the same solid angle, the same flux per pixel and the same exposure time (100 ms).

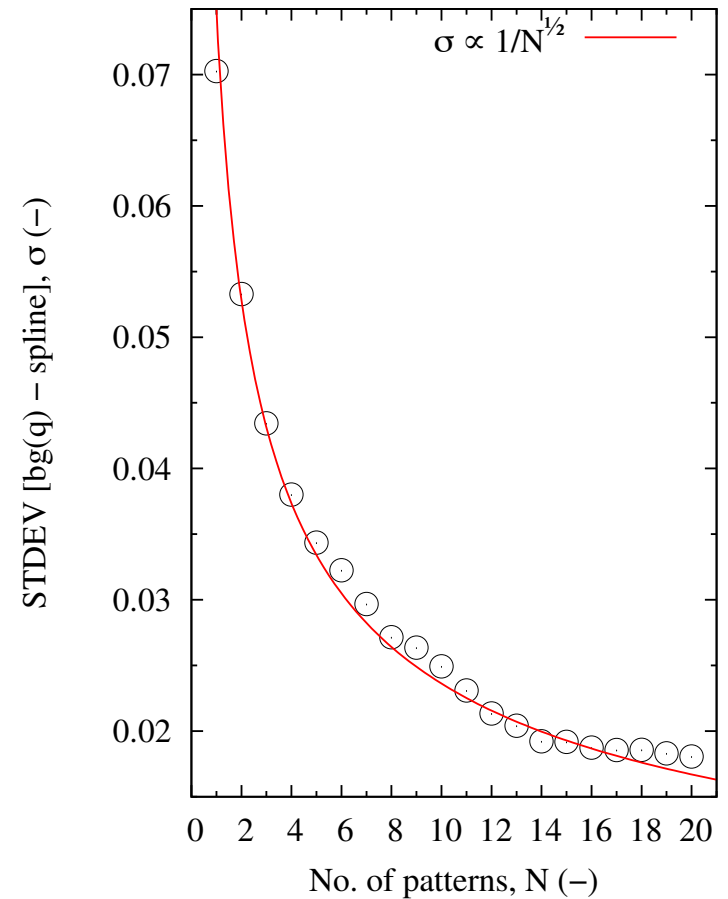
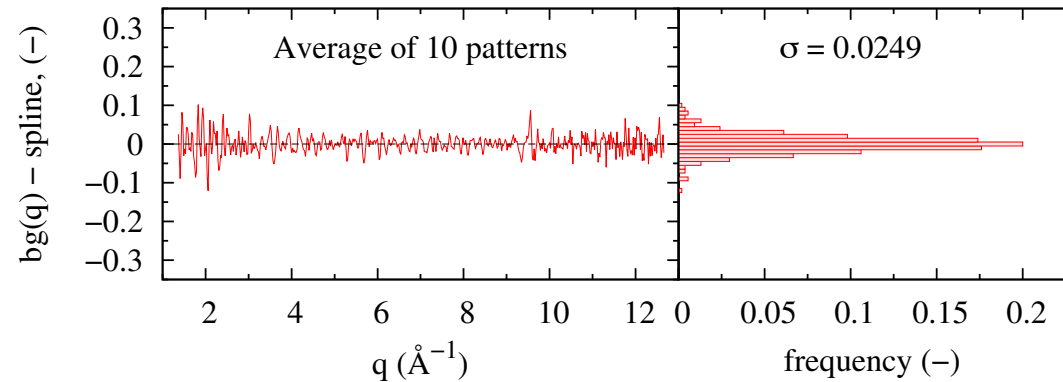
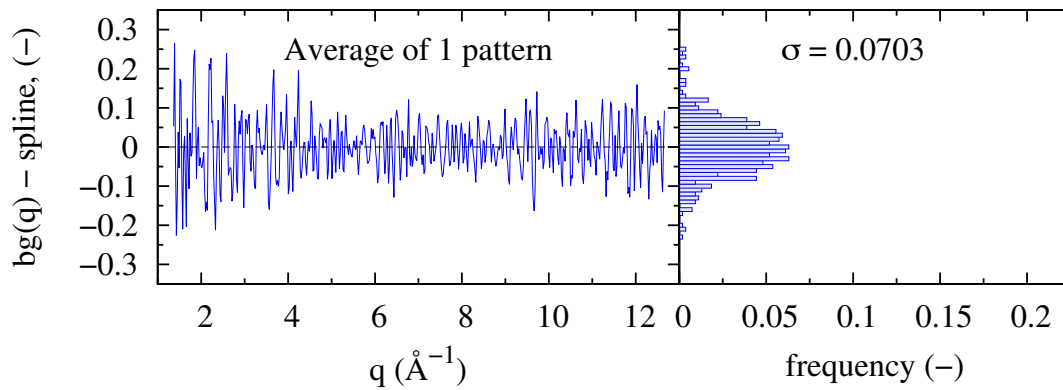


# XRPD (DLS, I12)



XRPD pattern of a  $\text{CeO}_2$  sample, taken at 55 keV,  
Using 0.2 mm slits and exposure time of **0.001** sec.  
Background intensity is mainly zero.  
Acknowledgment: Michael Drakopoulos, Oxana Magdysyuk (DLS)

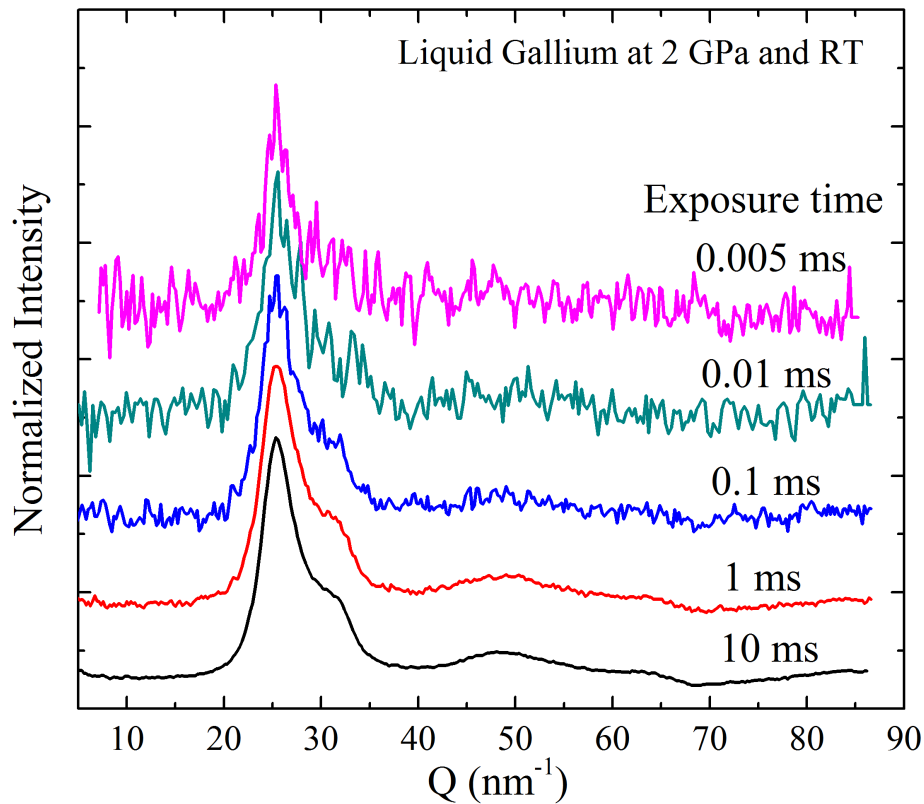
# PDF (DESY, P02)



Standard deviation in PDF measurements for data collected at 60 keV. Exposure Time per pattern is 0.1 s.

Bednarcik, J. and Liermann, H.P., poster presentation at DESY Users Meeting, 2016.

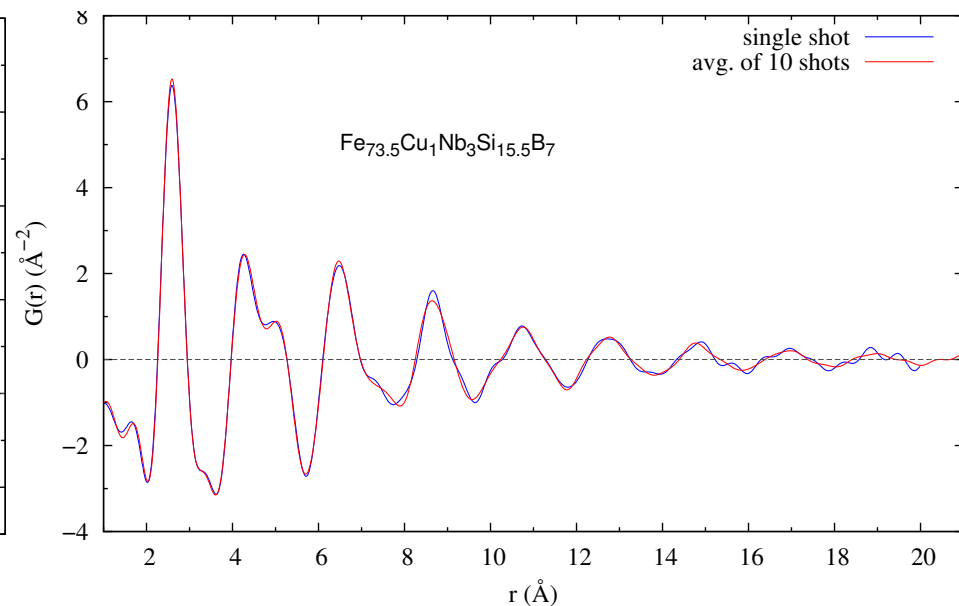
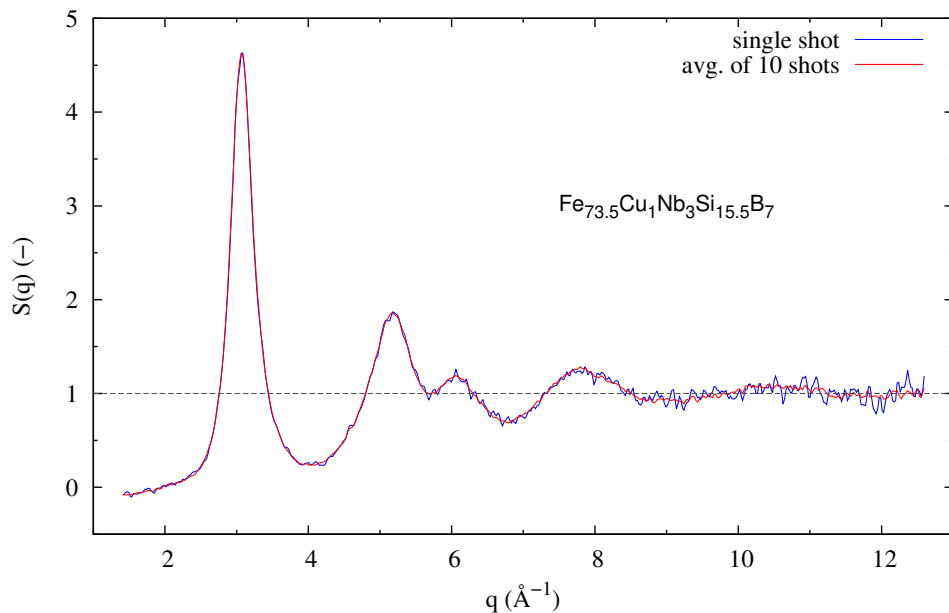
# PDF (APS, HPCAT)



Diffraction patterns of liquid Ga at 2 GPa collected at  $E=30.5$  keV.

Acknowledgement: Stanislav Sinogeikin, HPCAT, APS.

# PDF (DESY, P02)



To calculate the structure factor the measured intensities  $I(q)$  were corrected for only background and Compton scattering.

PDFs for 0.1s and 1s looks very similar. Almost no differences in the nearest neighborhood from 2  $\text{\AA}$  to 3.8  $\text{\AA}$ .

Bednarcik, J. and Liermann, H.P., poster presentation at DESY Users Meeting, 2016.

# ***XRPD-CT (ESRF, ID15)***

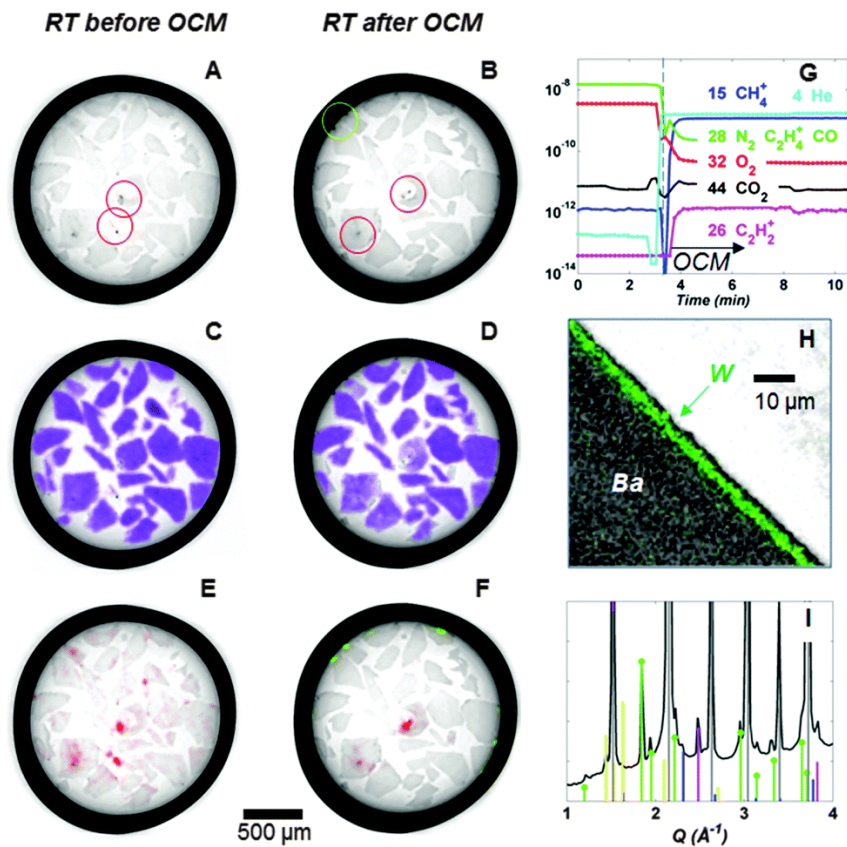
## ***1. Aim***

- Spatially and time-resolved identification of of a catalytic membrane reactor (CMR) during oxidative coupling of methane.*

## ***2. Method***

- XRD-CT*

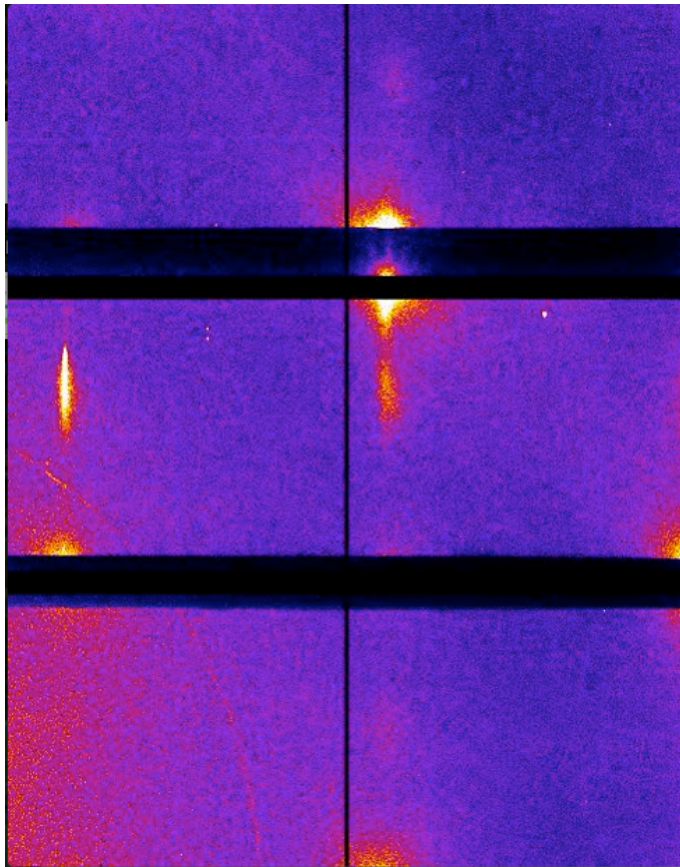
# XRPD-CT (ESRF, ID15)



Identification and determination of position of crystobalite (C,D),  $\text{Na}_2\text{WO}_4$ , and  $\text{Ba}_2\text{WO}_4$  (A, B, E, F) within the catalytic membrane reactor.

A. Vamvakeros *et al.*, *Chem. Commun.*, 2015, 51, 12752

# *PILATUS3 CdTe dynamics*



Successful tests at several beamlines  
And various applications

First PILATUS3 CdTe (2M) installed  
At ESRF, ID-15

PILATUS3 CdTe 1M  
ordered APS, Sector 13

...

Zhou Hua, Argonne National Laboratory.

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***Thank you for  
your attention!***

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